

://www.rfoe.net/ TEL:0755-83396822 FAX:0755-83376182 E-MAIL: szss20@163.com

HMC571

GaAs MMIC I/Q DOWNCONVERTER 21 - 25 GHz

Typical Applications

The HMC571 is ideal for:

- Point-to-Point and Point-to-Multi-Point Radio
- Military Radar, EW & ELINT
- Satellite Communications

Features

Conversion Gain: 11 dB Image Rejection: 24 dB 2 LO to RF Isolation: 40 dB Noise Figure: 3 dB Input IP3: +5 dBm Die Size: 2.33 x 2.51 x 0.10 mm

General Description

The HMC571 is a compact GaAs MMIC I/Q downconverter chip which provides a small signal conversion gain of 10 dB with a noise figure of 3 dB and 24 dB of image rejection across the frequency band. The device utilizes an LNA followed by an image reject mixer which is driven by an active x2 multiplier. The image reject mixer eliminates the need for a filter following the LNA, and removes thermal noise at the image frequency. I and Q mixer outputs are provided and an external 90° hybrid is needed to select the required sideband. All data shown below is taken with the chip mounted in a 50 Ohm test fixture and includes the effects of 1 mil diameter x 20 mil length bond wires on each port. This product is a much smaller alternative to hybrid style image reject mixer downconverter assemblies.



Electrical Specifications, $T_A = +25^{\circ}$ C, IF = 100 MHz, LO = +4 dBm, Vdd = 3.5 Vdc*

| Parameter | Min. | Тур. | Max. | Min. | Тур. | Max. | Units |
|--------------------------|------|-------------|------|------|----------|------|-------|
| Frequency Range, RF | | 21.2 - 23.7 | | | 21 - 25 | | GHz |
| Frequency Range, LO | | 9 - 14 | | | 9 - 14 | | |
| Frequency Range, IF | | DC - 3.5 | | | DC - 3.5 | | |
| Conversion Gain (As IRM) | 9 | 11 | | 8 | 11 | | dB |
| Noise Figure | | 3 | | | 3 | | dB |
| Image Rejection | 19 | 22 | | 19 | 24 | | dB |
| 1 dB Compression (Input) | -9 | -6 | | -11 | -8 | | dBm |
| 2 LO to RF Isolation | 38 | 45 | | 38 | 45 | | dB |
| 2 LO to IF Isolation | 28 | 32 | | 28 | 32 | | dB |
| IP3 (Input) | +2 | +5 | | -2 | +5 | | dBm |
| Amplitude Balance | | 0.3 | | | 0.7 | | dB |
| Phase Balance | | 5 | | | 5 | | Deg |
| Total Supply Current | | 125 | 165 | | 125 | 165 | mA |

Data taken as IRM with external IF hybrid



MICROWAVE CORPORATION V03.0808

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Data Taken As IRM With External IF Hybrid

Conversion Gain vs. Temperature



Conversion Gain vs. LO Drive



Input P1dB vs. Temperature



Image Rejection vs. Temperature



Return Loss



Input IP3 vs. LO Drive





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Quadrature Channel Data Taken Without IF Hybrid

Isolations



Amplitude Balance vs. LO Drive



Noise Figure vs. LO Drive, LO Frequency = 10.3 GHz





Phase Balance vs. LO Drive



Noise Figure vs. LO Drive, IF Frequency = 100 MHz



* Conversion gain data taken with external IF hybrid, LO frequency fixed at 10.3 GHz and RF varied

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MxN Spurious Outputs

| | nLO | | | | | |
|--|-----|----|----|----|----|--|
| mRF | 0 | 1 | 2 | 3 | 4 | |
| 0 | xx | 28 | 19 | 26 | 34 | |
| 1 | 33 | 30 | 0 | 29 | 44 | |
| 2 | 67 | 79 | 62 | 67 | 44 | |
| 3 | xx | xx | xx | 79 | 87 | |
| 4 | xx | xx | xx | xx | хх | |
| RF = 22 GHz @ -20 dBm LO = 10.5 GHz @ +4 dBm Data taken without IF hybrid All values in dBc below IF power level (1RF -2LO = 1 GHz) | | | | | | |

Absolute Maximum Ratings

| RF | +2 dBm |
|--|----------------|
| LO Drive | + 13 dBm |
| Vdd | 5.5V |
| Channel Temperature | 175°C |
| Continuous Pdiss (T=85°C) (derate 10.2 mW/°C above 85°C) | 920 mW |
| Thermal Resistance (R _{TH}) (channel to package bottom) | 98.3 °C/W |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature | -55 to +85 °C |
| ESD Sensitivity (HBM) | Class 1B |



ELECTROSTATIC SENSITIVE DEVICE OBSERVE HANDLING PRECAUTIONS

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Outline Drawing





Die Packaging Information ^[1]

| Standard | Alternate |
|-----------------|-----------|
| GP-1 (Gel Pack) | [2] |

 Refer to the "Packaging Information" section for die packaging dimensions.
For alternate packaging information contact Hittite NOTES:

- 1. ALL DIMENSIONS ARE IN INCHES [MM]
- 2. DIE THICKNESS IS 0.004"
- 3. BOND PAD METALIZATION: GOLD
- 4. BACKSIDE METALIZATION: GOLD
- 5. BACKSIDE METAL IS GROUND
- 6. OVERALL DIE SIZE ±0.002

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Pad Descriptions

| Pad Number | Function | Description | Interface Schematic |
|------------|----------|---|---------------------|
| 1 | VddRF | Power supply for RF LNA. External RF bypass capacitors are required. | VddRF O |
| 2 | VddLO2 | Power supply for second stage of LO amplifier. External RF bypass capacitors are required. | VddLO2 ○ |
| 3 | VddLO | Power supply for first stage of LO amplifier. External RF bypass capacitors are required. | VddLO O |
| 4 | LO | This pad is AC coupled and matched to 50 Ohms. | |
| 5 | IF1 | This pad is DC coupled for applications not requir- ing operation to DC. This port should be DC blocked externally using a series capacitor whose value has | IF1,IF2 O |
| 6 | IF2 | been chosen to pass the necessary frequency range. For operation to DC, this pad must not source /sink more than 3 mA of current or die non - function and possible die failure will result. | |
| 7 | RF | This pad is AC coupled and matched to 50 Ohms. | |
| | GND | The backside of the die must be connected to RF/DC ground. | |

Typical Application





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Assembly Drawing



3



GaAs MMIC I/Q DOWNCONVERTER 21 - 25 GHz

Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be brought as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm (3 mils).

Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025 mm (1 mil) diameter pure gold wire is recommended. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31 mm (12 mils).





